# Product Change Notification - KSRA-11PKSB895

Date: 16 Aug 2017

**Product Category:** Interface- Serial Peripherals

Notification subject: CCB 2771 Final Notice: Qualification of CuPdAu bond wire in selected products of the 150K (DLM)

wafer technologies available in 28L QFN package at NSEB assembly

PCN Status: **Notification text:** 

Final notification

#### Microchip Parts Affected:

Please open the attachments found in the attachments field below labeled as PCN\_#\_Affected\_CPN.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

#### **Description of Change:**

Qualification of palladium coated copper with gold flash (CuPdAu) bond wire in selected products of the 150K (DLM) wafer technologies available in 28L QFN package at NSEB assembly site.

#### Pre Change:

Using gold (Au) bond wire, 8600 die attach and G700LTD molding compound material

#### Post Change:

Using palladium coated copper with gold flash (CuPdAu) bond wire, 8600 die attach and G700LTD molding compound material

# Pre and Post Change Summary:

	Pre Change	Post Change			
Assembly Site	NSEB Assembly Site	NSEB Assembly Site			
Wire material	Au Wire	CuPdAu wire			
Die attach material	8600	8600			
Molding compound material	G700LTD	G700LTD			
Lead frame material	EFTEC-64T	EFTEC-64T			

# Impacts to Data Sheet:

#### **Change Impact:**

None

#### Reason for Change:

To improve manufacturability by qualifying palladium coated copper with gold flash (CuPdAu) bond wire

# Change Implementation Status:

In Progress

# **Estimated First Ship Date:**

September 16, 2017 (1737)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

# Time Table Summary:

	October 2016		->	August 2017			September 2017							
Workweek	41	42	43	44		31	32	33	34	35	36	37	38	39
Initial PCN Issue Date			Х											
Qual Report Availability								Х						
Final PCN Issue Date								х						
Estimated Implementation Date												Х		

#### Method to Identify Change:

Traceability code

# **Qualification Report:**

Please open the attachments included with this PCN labeled as PCN # Qual Report.

#### **Revision History:**

October 21, 2016: Issued initial notification.

August 16, 2017: Issued final notification. Attached the Qualification Report. Provided estimated first ship date on September 16, 2017

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s): PCN\_KSRA-11PKSB895\_Qual Report.pdf

PCN\_KSRA-11PKSB895\_Affected\_CPN.pdf PCN\_KSRA-11PKSB895\_Affected\_CPN.xlsx

Please contact your local Microchip sales office with questions or concerns regarding this notification.

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PCN\_KSRA-11PKSB895- Qualification of palladium coated copper with gold flash (CuPdAu) bond wire in selected products of the 150K (DLM) wafer technologies available in 28L QFN package at NSEB assembly site.

Affected Catalog Part Number (CPN)

PCN_KSRA-11PKSB895					
CATALOG_PART_NBR					
MCP23017-E/ML					
MCP23017T-E/ML					
MCP23S17-E/ML					
MCP23S17T-E/ML					